

CD4066B CMOS クワッド双方向スイッチ

1 特長

- 15V のデジタルまたは $\pm 7.5V$ のピーク・ツー・ピーク・スイッチング
- 15V 動作で 125 Ω (標準値) のオン抵抗
- 15V の信号入力範囲にわたってスイッチのオン抵抗の変動が 5 Ω 以下
- ピーク・ツー・ピーク信号範囲全体にわたってオン抵抗が平坦
- 高いオン / オフ出力電圧比 :
 $f_{is} = 10\text{kHz}$, $R_L = 1\text{k}\Omega$ で 80dB (標準値)
- 優れた直線性 : $f_{is} = 1\text{kHz}$, $V_{is} = 5V_{p-p}$,
 $V_{DD} - V_{SS} \geq 10V$, $R_L = 10\text{k}\Omega$ で 0.5% (標準値) 未満の歪み
- 非常に小さいオフ状態スイッチ・リークによる非常に小さいオフセット電流と高い実効オフ抵抗 : $V_{DD} - V_{SS} = 10V$, $T_A = 25^\circ\text{C}$ で 10pA (標準値)
- 非常に高い制御入力インピーダンス (制御回路を信号回路から絶縁) :
10¹² Ω (標準値)
- 小さなスイッチ間クロストーク : $f_{is} = 8\text{MHz}$, $R_L = 1\text{k}\Omega$ で -50dB (標準値)
- 整合した制御入力容量と信号出力容量 : 出力信号の過渡を低減
- スイッチ・オンでの周波数応答 = 40MHz (標準値)
- 20V で静止電流を 100% テスト済み
- 5V、10V、15V のパラメータ定格

2 アプリケーション

- アナログ信号のスイッチングと多重化 : 信号ゲーティング、変調器、スケルチ制御、復調器、チョッパ、整流スイッチ
- デジタル信号のスイッチングと多重化
- 伝送ゲート・ロジックの実装
- アナログからデジタル、デジタルからアナログへの変換
- 周波数、インピーダンス、位相、アナログ信号ゲインのデジタル制御
- ビルディング・オートメーション

3 概要

CD4066B デバイスは、アナログまたはデジタル信号の伝送 / 多重化を目的としたクワッド双方向スイッチです。

CD4016B デバイスとピン互換ですが、はるかに小さなオン抵抗を示します。また、このオン抵抗は信号入力範囲全体にわたって比較的一定です。

CD4066B デバイスは 4 つの双方向スイッチで構成され、それぞれ独立して制御できます。各スイッチの P と N の両方のデバイスが、制御信号によって同時にオンまたはオフにバイアスされます。図 17 に示すように、各スイッチの N チャネル・デバイスのウェルは入力 (スイッチがオンの場合) または V_{SS} (スイッチがオフの場合) に接続されます。この構成により、スイッチ・トランジスタのスレッショルド電圧の入力信号による変動が除去され、動作信号範囲全体にわたってオン抵抗が低く保たれます。

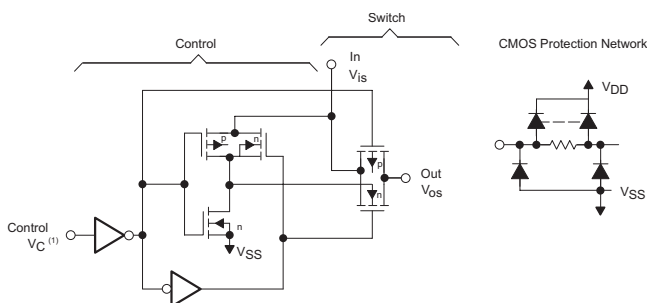
シングル・チャネル・スイッチに対する利点として、ピーク入力信号電圧スイングが電源電圧と完全に等しいことと、オン・インピーダンスが入力信号範囲全体にわたってより均一であることが挙げられます。しかし、サンプル・アンド・ホールドのアプリケーションには、CD4016B デバイスを推奨します。

製品情報⁽¹⁾

型番	パッケージ	本体サイズ(公称)
CD4066B	PDIP (14)	19.30mm×6.35mm
	CDIP (14)	19.50mm×6.92mm
	SOIC (14)	8.65mm×3.91mm
	SOP (14)	10.30mm×5.30mm
	TSSOP (14)	5.00mm × 4.40mm

(1) 利用可能なすべてのパッケージについては、このデータシートの末尾にある注文情報を参照してください。

デジタル制御ロジックによる双方向信号伝送



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目次

1	特長	1	8.3	Feature Description	14
2	アプリケーション	1	8.4	Device Functional Modes	14
3	概要	1	9	Application and Implementation	15
4	改訂履歴	2	9.1	Application Information	15
5	Pin Configuration and Functions	3	9.2	Typical Application	15
6	Specifications	4	10	Power Supply Recommendations	17
6.1	Absolute Maximum Ratings	4	11	Layout	17
6.2	ESD Ratings	4	11.1	Layout Guidelines	17
6.3	Recommended Operating Conditions	4	11.2	Layout Example	17
6.4	Thermal Information	4	12	デバイスおよびドキュメントのサポート	18
6.5	Electrical Characteristics	5	12.1	ドキュメントの更新通知を受け取る方法	18
6.6	Switching Characteristics	8	12.2	コミュニティ・リソース	18
6.7	Typical Characteristics	9	12.3	商標	18
7	Parameter Measurement Information	10	12.4	静電気放電に関する注意事項	18
8	Detailed Description	14	12.5	Glossary	18
8.1	Overview	14	13	メカニカル、パッケージ、および注文情報	18
8.2	Functional Block Diagram	14			

4 改訂履歴

資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

Revision G (June 2017) から Revision H に変更	Page
• Added Junction Temperature details to the <i>Absolute Maximum Ratings</i> table	4

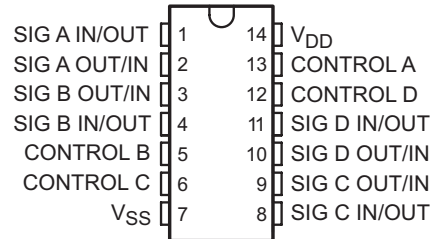
Revision F (March 2017) から Revision G に変更	Page
• Changed From: V_{SS} To: Hi-Z in the SIG OUT/IN column of	14

Revision E (September 2016) から Revision F に変更	Page
• Corrected the $r_{on} V_{DD} = 10$ V values in the <i>Electrical Characteristics</i> table.	7
• Corrected the y axis scale in Figure 6	9

Revision D (September 2003) から Revision E に変更	Page
• 「ESD 定格」表、「機能説明」セクション、「デバイスの機能モード」セクション、「アプリケーションと実装」セクション、「電源に関する推奨事項」セクション、「レイアウト」セクション、「デバイスおよびドキュメントのサポート」セクション、「メカニカル、パッケージ、および注文情報」セクション 追加	1
• 「注文情報」表を削除	1
• Changed values in the <i>Thermal Information</i> table to align with JEDEC standards	4

5 Pin Configuration and Functions

**N, J, D, NS, or PW Packages
14-Pin PDIP, CDIP, SOIC, SO, or TSSOP
Top View**



Pin Functions

PIN		I/O	DESCRIPTION
NO.	NAME		
1	SIG A IN/OUT	I/O	Input/Output for Switch A
2	SIG A OUT/IN	I/O	Output/Input for Switch A
3	SIG B OUT/IN	I/O	Output/Input for Switch B
4	SIG B IN/OUT	I/O	Input/Output for Switch B
5	CONTROL B	I	Control pin for Switch B
6	CONTROL C	I	Control pin for Switch C
7	V _{SS}	—	Low Voltage Power Pin
8	SIG C IN/OUT	I/O	Input/Output for Switch C
9	SIG C OUT/IN	I/O	Output/Input for Switch C
10	SIG D OUT/IN	I/O	Output/Input for Switch D
11	SIG D IN/OUT	I/O	Input/Output for Switch D
12	CONTROL D	I	Control Pin for D
13	CONTROL A	I	Control Pin for A
14	V _{DD}	—	Power Pin

6 Specifications

6.1 Absolute Maximum Ratings

Over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			MIN	MAX	UNIT
V _{DD}	DC supply-voltage	Voltages referenced to V _{SS} pin	-0.5	20	V
V _{is}	Input voltage	All inputs	-0.5	V _{DD} + 0.5	V
I _{IN}	DC input current	Any one input		±10	mA
T _{JMAX1}	Maximum junction temperature, ceramic package			175	°C
T _{JMAX2}	Maximum junction temperature, plastic package			150	°C
T _{stg}	Storage temperature		-65	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings

		VALUE	UNIT
V _(ESD)	Electrostatic discharge	±500	V
		±1500	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
 (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

Over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V _{DD}	Supply voltage		3	18	V
T _A	Operating free-air temperature		-55	125	°C

6.4 Thermal Information

THERMAL METRIC ⁽¹⁾	CD4066B				UNIT	
	N (PDIP)	D (SOIC)	NS (SO)	PW (TSSOP)		
	14 PINS	14 PINS	14 PINS	14 PINS		
R _{θJA}	Junction-to-ambient thermal resistance	53.7	89.5	88.2	119.5	°C/W
R _{θJC(top)}	Junction-to-case (top) thermal resistance	41.0	49.7	46.1	48.2	°C/W
R _{θJB}	Junction-to-board thermal resistance	33.6	43.8	47.0	61.2	°C/W
ψ _{JT}	Junction-to-top characterization parameter	25.8	17.4	16.3	5.5	°C/W
ψ _{JB}	Junction-to-board characterization parameter	33.5	43.5	46.6	60.6	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

6.5 Electrical Characteristics

Over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V _{os}	Switch output voltage	V _{DD} = 5 V V _{is} = 0 V			0.4	V
		V _{DD} = 5 V V _{is} = 5 V	4.6			V
		V _{DD} = 10 V V _{is} = 0 V			0.5	V
		V _{DD} = 10 V V _{is} = 10 V	9.5			V
		V _{DD} = 15 V V _{is} = 0 V			1.5	V
		V _{DD} = 15 V V _{is} = 15 V	13.5			V
Δr _{on}	On-state resistance difference between any two switches R _L = 10 kΩ, V _C = V _{DD}	V _{DD} = 5 V		15		Ω
		V _{DD} = 10 V		10		
		V _{DD} = 15 V		5		
THD	Total harmonic distortion	V _C = V _{DD} = 5 V, V _{SS} = -5 V, V _{is(p-p)} = 5 V (sine wave centered on 0 V), R _L = 10 kΩ, f _{is} = 1-kHz sine wave		0.4%		
	-3-dB cutoff frequency (switch on)	V _C = V _{DD} = 5 V, V _{SS} = -5 V, V _{is(p-p)} = 5 V (sine wave centered on 0 V), R _L = 1 kΩ		40		MHz
	-50-dB feedthrough frequency (switch off)	V _C = V _{SS} = -5 V, V _{is(p-p)} = 5 V (sine wave centered on 0 V), R _L = 1 kΩ		1		MHz
	-50-dB crosstalk frequency	V _{C(A)} = V _{DD} = 5 V, V _{C(B)} = V _{SS} = -5 V, V _{is(A)} = 5 V _{p-p} , 50-Ω source, R _L = 1 kΩ		8		MHz
C _{is}	Input capacitance	V _{DD} = 5 V, V _C = V _{SS} = -5 V		8		pF
C _{os}	Output capacitance	V _{DD} = 5 V, V _C = V _{SS} = -5 V		8		pF
C _{ios}	Feedthrough	V _{DD} = 5 V, V _C = V _{SS} = -5 V		0.5		pF
V _{IHC}	Control input, high voltage	See Figure 7	V _{DD} = 5 V	3.5		V
			V _{DD} = 10 V	7		
			V _{DD} = 15 V	11		
	Crosstalk (control input to signal output)	V _C = 10 V (square wave), t _r , t _f = 20 ns, R _L = 10 kΩ V _{DD} = 10 V		50		mV
	Turnon and turnoff propagation delay	V _{IN} = V _{DD} , t _r , t _f = 20 ns, C _L = 50 pF, R _L = 1 kΩ	V _{DD} = 5 V	35	70	ns
			V _{DD} = 10 V	20	40	
			V _{DD} = 15 V	15	30	
	Maximum control input repetition rate	V _{is} = V _{DD} , V _{SS} = GND, R _L = 1 kΩ to GND, C _L = 50 pF, V _C = 10 V (square wave centered on 5 V), t _r , t _f = 20 ns, V _{os} = 1/2 V _{os} at 1 kHz	V _{DD} = 5 V	6		MHz
			V _{DD} = 10 V	9		
			V _{DD} = 15 V	9.5		
C _I	Input capacitance			5	7.5	pF

Electrical Characteristics (continued)

Over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
I_{is} Switch input current	$V_{DD} = 5\text{ V}$ $V_{is} = 0\text{ V}$	$T_A = -55^\circ\text{C}$		0.64	mA
		$T_A = -40^\circ\text{C}$		0.61	
		$T_A = 25^\circ\text{C}$	0.51		
		$T_A = 85^\circ\text{C}$		0.42	
		$T_A = 125^\circ\text{C}$		0.36	
	$V_{DD} = 5\text{ V}$ $V_{is} = 5\text{ V}$	$T_A = -55^\circ\text{C}$		-0.64	mA
		$T_A = -40^\circ\text{C}$		-0.61	
		$T_A = 25^\circ\text{C}$	-0.51		
		$T_A = 85^\circ\text{C}$		-0.42	
		$T_A = 125^\circ\text{C}$		-0.36	
	$V_{DD} = 10\text{ V}$ $V_{is} = 0\text{ V}$	$T_A = -55^\circ\text{C}$		1.6	mA
		$T_A = -40^\circ\text{C}$		1.5	
		$T_A = 25^\circ\text{C}$	1.3		
		$T_A = 85^\circ\text{C}$		1.1	
		$T_A = 125^\circ\text{C}$		0.9	
	$V_{DD} = 10\text{ V}$ $V_{is} = 10\text{ V}$	$T_A = -55^\circ\text{C}$		-1.6	mA
		$T_A = -40^\circ\text{C}$		-1.5	
		$T_A = 25^\circ\text{C}$	-1.3		
		$T_A = 85^\circ\text{C}$		-1.1	
		$T_A = 125^\circ\text{C}$		-0.9	
	$V_{DD} = 15\text{ V}$ $V_{is} = 0\text{ V}$	$T_A = -55^\circ\text{C}$		4.2	mA
		$T_A = -40^\circ\text{C}$		4	
		$T_A = 25^\circ\text{C}$	3.4		
		$T_A = 85^\circ\text{C}$		2.8	
$T_A = 125^\circ\text{C}$			2.4		
$V_{DD} = 15\text{ V}$ $V_{is} = 15\text{ V}$	$T_A = -55^\circ\text{C}$		-4.2	mA	
	$T_A = -40^\circ\text{C}$		-4		
	$T_A = 25^\circ\text{C}$	-3.4			
	$T_A = 85^\circ\text{C}$		-2.8		
	$T_A = 125^\circ\text{C}$		-2.4		

Electrical Characteristics (continued)

Over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT	
I_{DD}	Quiescent device current	$V_{IN} = 0$ to 5 V $V_{DD} = 5$ V	$T_A = -55^\circ\text{C}$			0.25	μA	
			$T_A = -40^\circ\text{C}$			0.25		
			$T_A = 25^\circ\text{C}$		0.01	0.25		
			$T_A = 85^\circ\text{C}$			7.5		
			$T_A = 125^\circ\text{C}$			7.5		
		$V_{IN} = 0$ to 10 V $V_{DD} = 10$ V	$T_A = -55^\circ\text{C}$			0.5	μA	
			$T_A = -40^\circ\text{C}$			0.5		
			$T_A = 25^\circ\text{C}$		0.01	0.5		
			$T_A = 85^\circ\text{C}$			15		
			$T_A = 125^\circ\text{C}$			15		
		$V_{IN} = 0$ to 15 V $V_{DD} = 15$ V	$T_A = -55^\circ\text{C}$			1	μA	
			$T_A = -40^\circ\text{C}$			1		
			$T_A = 25^\circ\text{C}$		0.01	1		
			$T_A = 85^\circ\text{C}$			30		
			$T_A = 125^\circ\text{C}$			30		
		$V_{IN} = 0$ to 20 V $V_{DD} = 20$ V	$T_A = -55^\circ\text{C}$			5	μA	
$T_A = -40^\circ\text{C}$				5				
$T_A = 25^\circ\text{C}$			0.02	5				
$T_A = 85^\circ\text{C}$				150				
$T_A = 125^\circ\text{C}$				150				
r_{on}	On-state resistance (max)	to $\frac{(V_{DD} - V_{SS})}{V_C = V_{DD}^2}$, $R_L = 10\text{ k}\Omega$ returned $V_{is} = V_{SS}$ to V_{DD}	$V_{DD} = 5$ V	$T_A = -55^\circ\text{C}$		800	Ω	
				$T_A = -40^\circ\text{C}$		850		
				$T_A = 25^\circ\text{C}$		470		1050
				$T_A = 85^\circ\text{C}$		1200		
				$T_A = 125^\circ\text{C}$		1300		
			$V_{DD} = 10$ V	$T_A = -55^\circ\text{C}$		310		
				$T_A = -40^\circ\text{C}$		330		
				$T_A = 25^\circ\text{C}$		180		400
				$T_A = 85^\circ\text{C}$		500		
				$T_A = 125^\circ\text{C}$		500		
			$V_{DD} = 15$ V	$T_A = -55^\circ\text{C}$		200		
				$T_A = -40^\circ\text{C}$		210		
$T_A = 25^\circ\text{C}$		125		240				
$T_A = 85^\circ\text{C}$		300						
$T_A = 125^\circ\text{C}$		320						

Electrical Characteristics (continued)

Over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
V_{ILC}	Control input, low voltage (max)	$ I_{is} < 10 \mu A$, $V_{is} = V_{SS}$, $V_{OS} = V_{DD}$, and $V_{is} = V_{DD}$, $V_{OS} = V_{SS}$	$V_{DD} = 5 V$	$T_A = -55^\circ C$		1	V
				$T_A = -40^\circ C$		1	
				$T_A = 25^\circ C$		1	
				$T_A = 85^\circ C$		1	
				$T_A = 125^\circ C$		1	
			$V_{DD} = 10 V$	$T_A = -55^\circ C$		2	
				$T_A = -40^\circ C$		2	
				$T_A = 25^\circ C$		2	
				$T_A = 85^\circ C$		2	
				$T_A = 125^\circ C$		2	
			$V_{DD} = 15 V$	$T_A = -55^\circ C$		2	
				$T_A = -40^\circ C$		2	
				$T_A = 25^\circ C$		2	
				$T_A = 85^\circ C$		2	
				$T_A = 125^\circ C$		2	
I_{IN}	Input current (max)	$V_{is} \leq V_{DD}$, $V_{DD} - V_{SS} = 18 V$, $V_{CC} \leq V_{DD} - V_{SS}$ $V_{DD} = 18 V$	$T_A = -55^\circ C$			± 0.1	μA
			$T_A = -40^\circ C$			± 0.1	
			$T_A = 25^\circ C$		$\pm 10^{-5}$	± 0.1	
			$T_A = 85^\circ C$			± 1	
			$T_A = 125^\circ C$			± 1	

6.6 Switching Characteristics

 $T_A = 25^\circ C$

PARAMETER	FROM	TO	TEST CONDITIONS	V_{CC}	MIN	TYP	MAX	UNIT
t_{pd}	Signal input	Signal output	$V_{IN} = V_{DD}$, $t_r, t_f = 20 ns$, $C_L = 50 pF$, $R_L = 1 k\Omega$	5 V		20	40	ns
				10 V		10	20	
				15 V		7	15	
t_{ph}	Signal input	Signal output	$V_{IN} = V_{DD}$, $t_r, t_f = 20 ns$, $C_L = 50 pF$, $R_L = 1 k\Omega$	5 V		35	70	ns
				10 V		20	40	
				15 V		15	30	
t_{phl}	Signal input	Signal output	$V_{IN} = V_{DD}$, $t_r, t_f = 20 ns$, $C_L = 50 pF$, $R_L = 1 k\Omega$	5 V		35	70	ns
				10 V		20	40	
				15 V		15	30	

6.7 Typical Characteristics

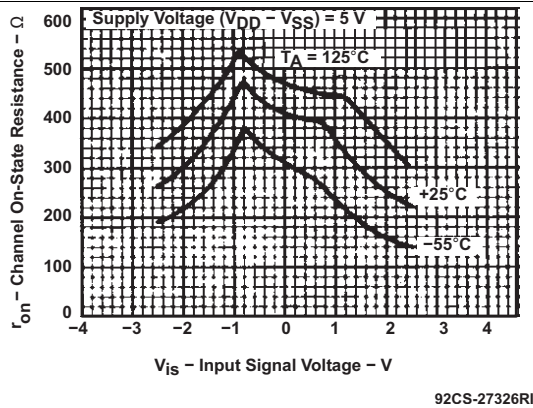


Figure 1. Typical ON-State Resistance vs Input Signal Voltage (All Types)

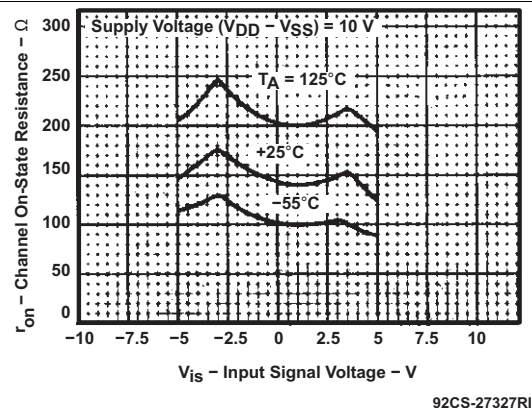


Figure 2. Typical ON-State Resistance vs Input Signal Voltage (All Types)

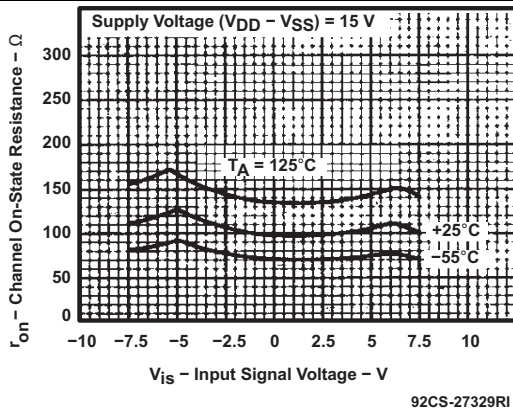


Figure 3. Typical ON-State Resistance vs Input Signal Voltage (All Types)

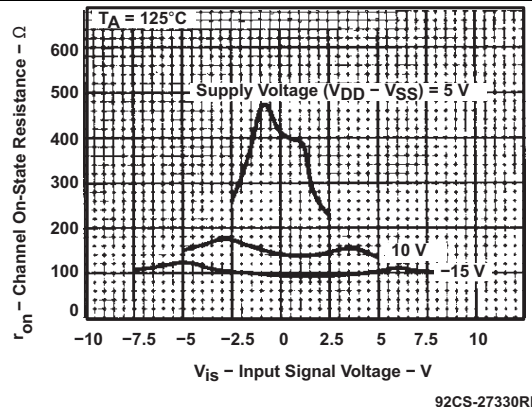


Figure 4. Typical ON-State Resistance vs Input Signal Voltage (All Types)

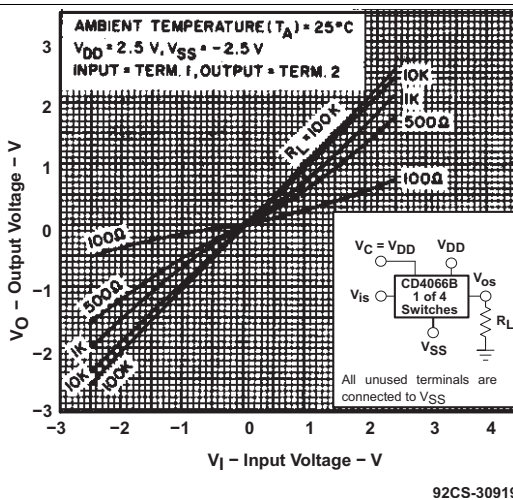


Figure 5. Typical ON Characteristics for 1 of 4 Channels

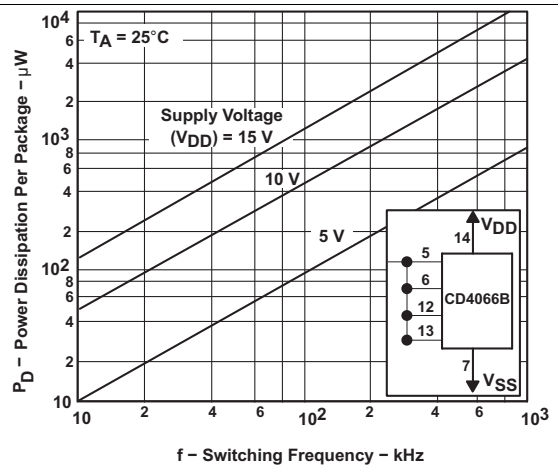
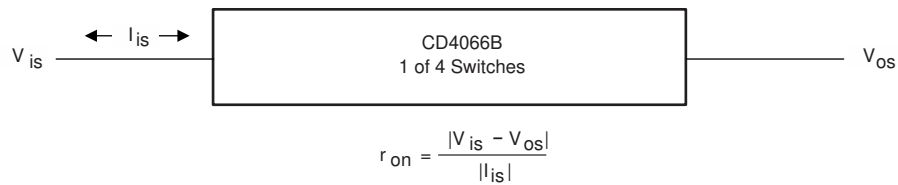


Figure 6. Power Dissipation per Package vs Switching Frequency

7 Parameter Measurement Information



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Figure 7. Determination of r_{on} as a Test Condition for Control-Input High-Voltage (V_{IHC}) Specification

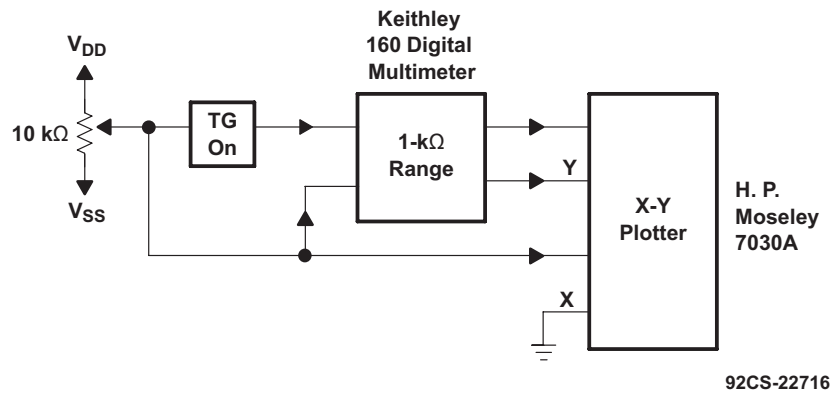
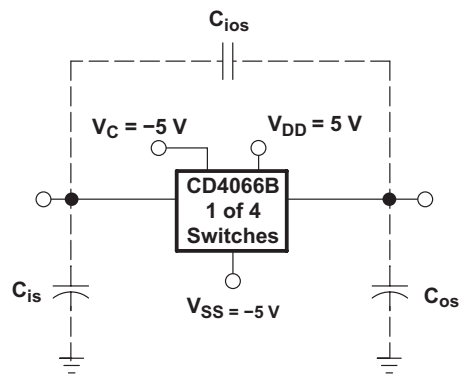


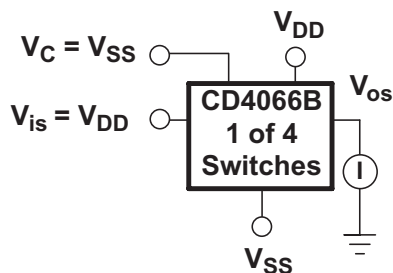
Figure 8. Channel On-State Resistance Measurement Circuit



Measured on Boonton capacitance bridge, model 75a (1 MHz);
test-fixture capacitance nulled out.

Figure 9. Typical On Characteristics for One of Four Channels

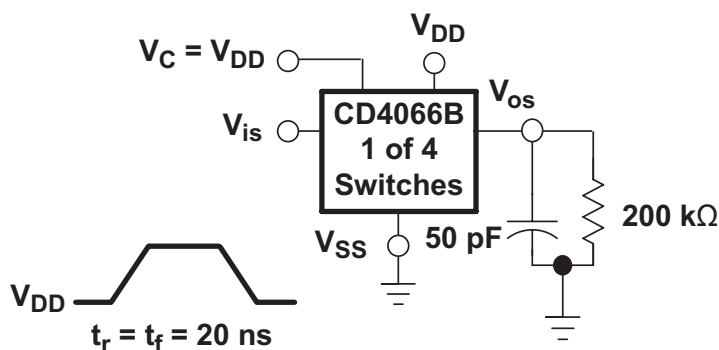
Parameter Measurement Information (continued)



92CS-30922

All unused terminals are connected to V_{SS} .

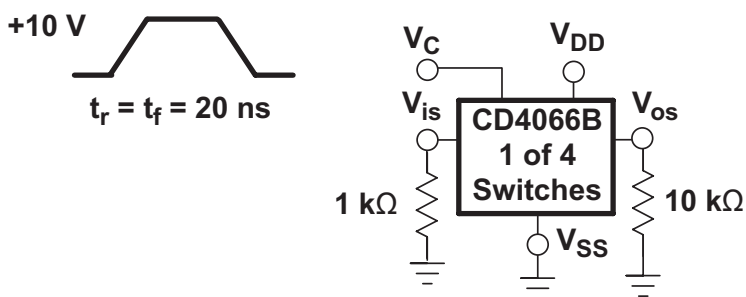
Figure 10. Off-Switch Input or Output Leakage



92CS-30923

All unused terminals are connected to V_{SS} .

Figure 11. Propagation Delay Time Signal Input (V_{is}) to Signal Output (V_{os})

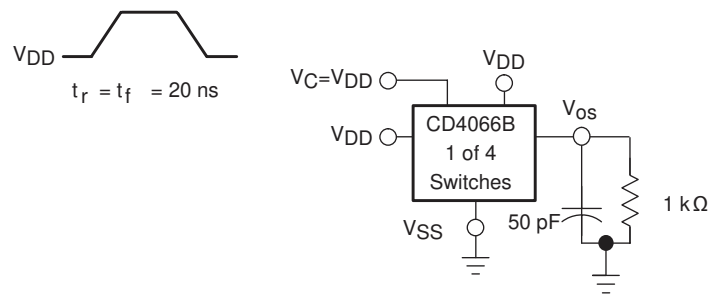


92CS-30924

All unused terminals are connected to V_{SS} .

Figure 12. Crosstalk-Control Input to Signal Output

Parameter Measurement Information (continued)

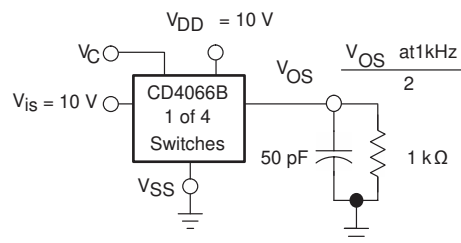
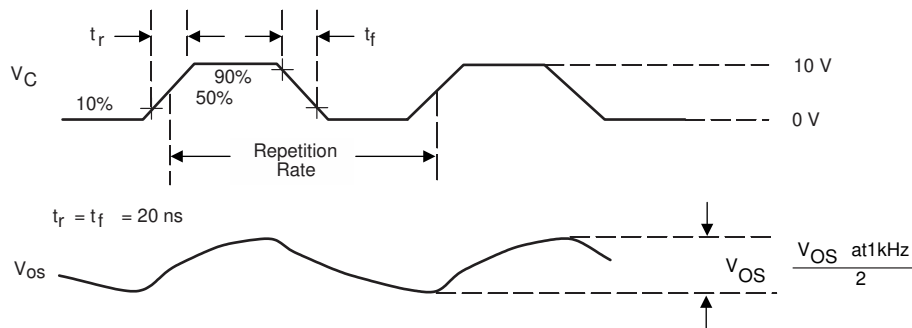


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All unused pins are connected to V_{SS} .

Delay is measured at V_{OS} level of +10% from ground (turn-on) or on-state output level (turn-off).

Figure 13. Propagation Delay, t_{PLH} , t_{PHL} Control-Signal Output

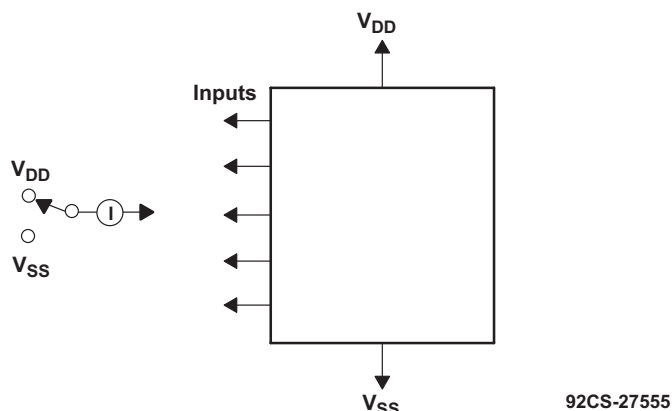


Copyright © 2016, Texas Instruments Incorporated

All unused pins are connected to V_{SS} .

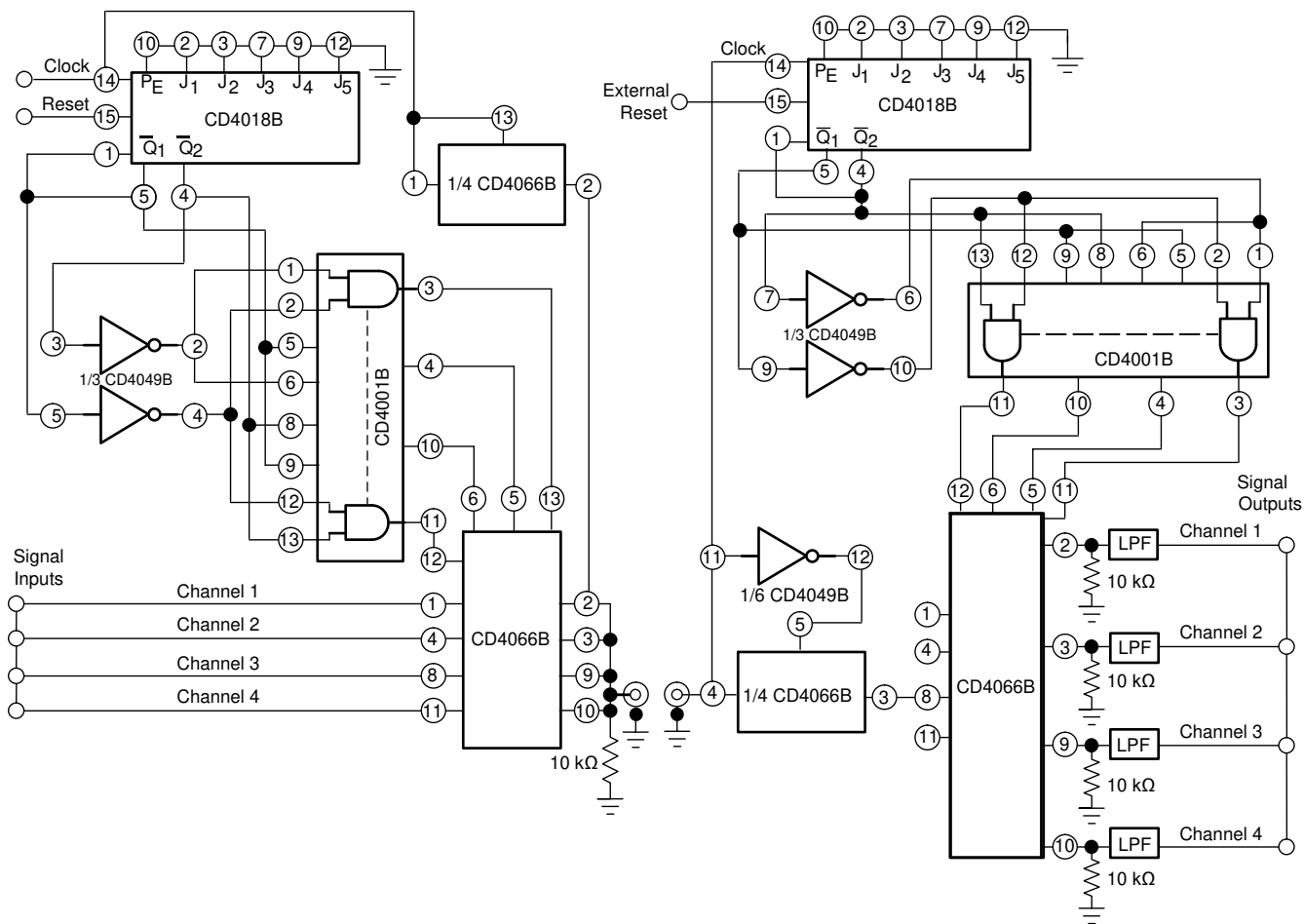
Figure 14. Maximum Allowable Control-Input Repetition Rate

Parameter Measurement Information (continued)



Measure inputs sequentially to both V_{DD} and V_{SS} . Connect all unused inputs to either V_{DD} or V_{SS} . Measure control inputs only.

Figure 15. Input Leakage-Current Test Circuit



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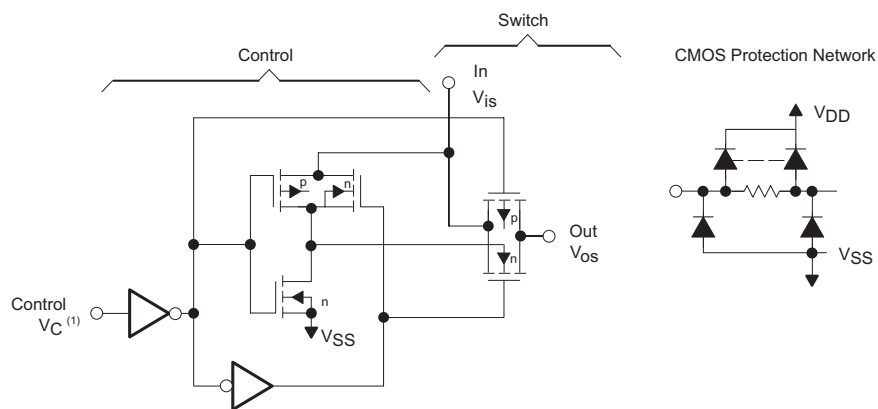
Figure 16. Four-Channel PAM Multiplex System Diagram

8 Detailed Description

8.1 Overview

CD4066B has four independent digitally controlled analog switches with a bias voltage of V_{SS} to allow for different voltage levels to be used for low output. Both the p and the n devices in a given switch are biased on or off simultaneously by the control signal. As shown in Figure 17, the well of the n-channel device on each switch is tied to either the input (when the switch is on) or to V_{SS} (when the switch is off). Thus, when the control of the device is low, the output of the switch goes to V_{SS} and when the control is high the output of the device goes to V_{DD} .

8.2 Functional Block Diagram



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- (1) All control inputs are protected by the CMOS protection network.
- (2) All p substrates are connected to V_{DD} .
- (3) Normal operation control-line biasing: switch on (logic 1), $V_C = V_{DD}$; switch off (logic 0), $V_C = V_{SS}$.
- (4) Signal-level range: $V_{SS} \leq V_{is} \leq V_{DD}$.

Figure 17. Schematic Diagram of One-of-Four Identical Switches and Associated Control Circuitry

8.3 Feature Description

Each switch has different control pins, which allows for more options for the outputs. Bias Voltage allows the device to output a voltage other than 0 V when the device control is low. The CD4066B has a large absolute maximum voltage for V_{DD} of 20 V.

8.4 Device Functional Modes

Added Junction Temperature details to the *Absolute Maximum Ratings* table lists the functions of this device.

Table 1. Function Table

INPUTS		OUTPUT
SIG IN/OUT	CONTROL	SIG OUT/IN
H	H	H
L	H	L
X	L	Hi-Z

9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

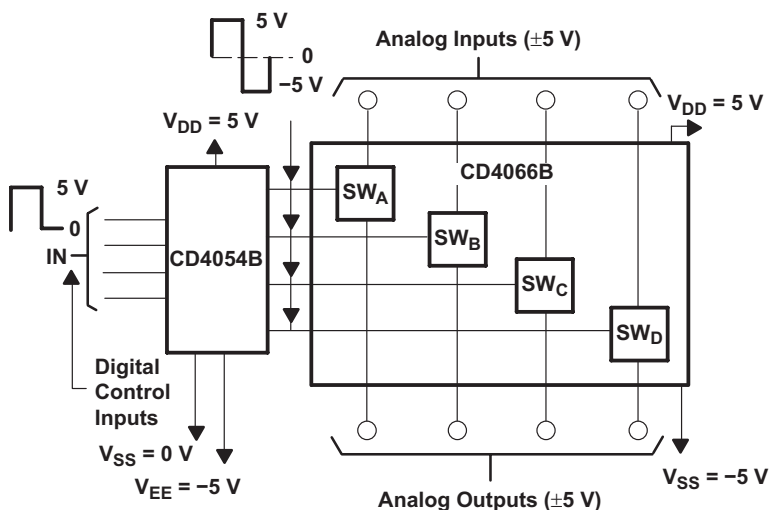
9.1 Application Information

In applications that employ separate power sources to drive V_{DD} and the signal inputs, the V_{DD} current capability should exceed V_{DD}/R_L (R_L = effective external load of the four CD4066B device bilateral switches). This provision avoids any permanent current flow or clamp action on the V_{DD} supply when power is applied or removed from the CD4066B device.

In certain applications, the external load-resistor current can include both V_{DD} and signal-line components. To avoid drawing V_{DD} current when switch current flows into pins 1, 4, 8, or 11, the voltage drop across the bidirectional switch must not exceed 0.8 V (calculated from r_{on} values shown).

No V_{DD} current flows through R_L if the switch current flows into pins 2, 3, 9, or 10.

9.2 Typical Application



92CS-30927

Figure 18. Bidirectional Signal Transmission Through Digital Control Logic

9.2.1 Design Requirements

This device uses CMOS technology and has balanced output drive. Avoid bus contention because it can drive currents in excess of maximum limits. The high drive also creates fast edges into light loads, so consider routing and load conditions to prevent ringing.

9.2.2 Detailed Design Procedure

1. Recommended Input Conditions:
 - For rise time and fall time specifications, see $\Delta t/\Delta v$ in [Recommended Operating Conditions](#).
 - For specified high and low levels, see V_{IH} and V_{IL} in [Recommended Operating Conditions](#).
2. Recommended Output Conditions:
 - Load currents should not exceed ± 10 mA.

Typical Application (continued)

9.2.3 Application Curve

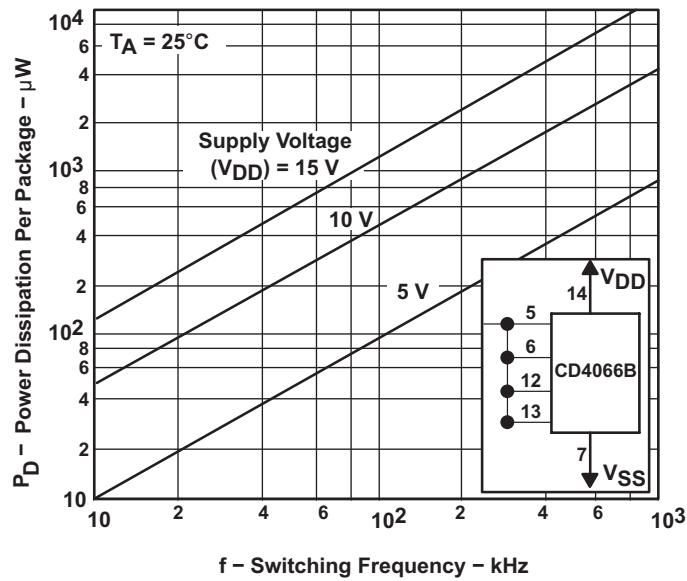


Figure 19. Power Dissipation vs. Switching Frequency

10 Power Supply Recommendations

The power supply can be any voltage between the MIN and MAX supply voltage rating located in [Recommended Operating Conditions](#).

Each VCC pin should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, 0.1- μF is recommended; if there are multiple VCC pins, then 0.01- μF or 0.022- μF is recommended for each power pin. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. A 0.1- μF and a 1- μF are commonly used in parallel. The bypass capacitor should be installed as close to the power pin as possible for best results.

11 Layout

11.1 Layout Guidelines

When using multiple bit logic devices inputs must never float.

In many cases, functions or parts of functions of digital logic devices are unused, for example, when only two inputs of a triple-input *and* gate are used or only 3 of the 4 buffer gates are used. Such input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that should be applied to any particular unused input depends on the function of the device. Generally they are tied to GND or VCC, whichever makes more sense or is more convenient. It is generally acceptable to float outputs, unless the part is a transceiver. If the transceiver has an output enable pin, it disables the output section of the part when asserted. This does not disable the input section of the I/Os, so they cannot float when disabled.

11.2 Layout Example

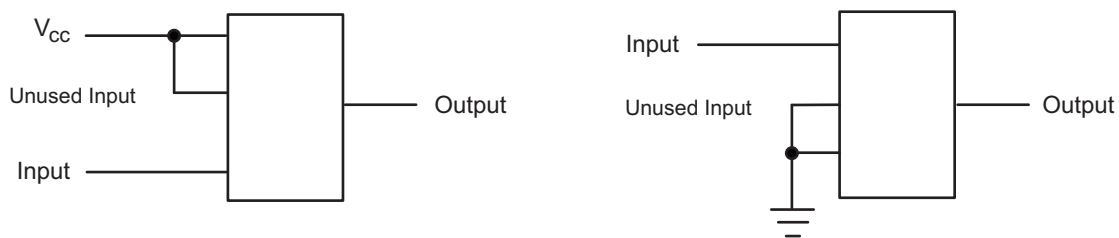


Figure 20. Diagram for Unused Inputs

12 デバイスおよびドキュメントのサポート

12.1 ドキュメントの更新通知を受け取る方法

ドキュメントの更新についての通知を受け取るには、ti.comのデバイス製品フォルダを開いてください。右上の「アラートを受け取る」をクリックして登録すると、変更されたすべての製品情報に関するダイジェストを毎週受け取れます。変更の詳細については、修正されたドキュメントに含まれている改訂履歴をご覧ください。

12.2 コミュニティ・リソース

[TI E2E™ support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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静電気放電はわずかな性能の低下から完全なデバイスの故障に至るまで、様々な損傷を与えます。高精度の集積回路は、損傷に対して敏感であり、極めてわずかなパラメータの変化により、デバイスに規定された仕様に適合しなくなる場合があります。

12.5 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

13 メカニカル、パッケージ、および注文情報

以降のページには、メカニカル、パッケージ、および注文に関する情報が記載されています。この情報は、そのデバイスについて利用可能な最新のデータです。このデータは予告なく変更されることがあり、ドキュメントが改訂される場合もあります。本データシートのブラウザ版を使用されている場合は、画面左側の説明をご覧ください。

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CD4066BE	ACTIVE	PDIP	N	14	25	RoHS & Green	NIPDAU SN	N / A for Pkg Type	-55 to 125	CD4066BE	Samples
CD4066BEE4	ACTIVE	PDIP	N	14	25	RoHS & Non-Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD4066BE	Samples
CD4066BF	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	CD4066BF	Samples
CD4066BF3A	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	CD4066BF3A	Samples
CD4066BM	LIFEBUY	SOIC	D	14	50	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4066BM	
CD4066BM96	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU SN	Level-1-260C-UNLIM	-55 to 125	CD4066BM	Samples
CD4066BM96E4	LIFEBUY	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4066BM	
CD4066BM96G4	LIFEBUY	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4066BM	
CD4066BMT	LIFEBUY	SOIC	D	14	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4066BM	
CD4066BNS	LIFEBUY	SO	NS	14	50	RoHS & Green	NIPDAU	Level-1-260C-UNLIM		CD4066B	
CD4066BNSR	ACTIVE	SO	NS	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4066B	Samples
CD4066BPW	LIFEBUY	TSSOP	PW	14	90	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM066B	
CD4066BPWG4	LIFEBUY	TSSOP	PW	14	90	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM066B	
CD4066BPWR	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU SN	Level-1-260C-UNLIM	-55 to 125	CM066B	Samples
CD4066BPWRG4	LIFEBUY	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM066B	
JM38510/05852BCA	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	JM38510/05852BCA	Samples
M38510/05852BCA	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	JM38510/05852BCA	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSELETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of ≤ 1000 ppm threshold. Antimony trioxide based flame retardants must also meet the ≤ 1000 ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF CD4066B, CD4066B-MIL :

- Catalog : [CD4066B](#)

- Automotive : [CD4066B-Q1](#), [CD4066B-Q1](#)

- Military : [CD4066B-MIL](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

- Military - QML certified for Military and Defense Applications

TAPE AND REEL INFORMATION

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD4066BM96	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
CD4066BM96G4	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
CD4066BM96G4	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
CD4066BMT	SOIC	D	14	250	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
CD4066BNSR	SO	NS	14	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
CD4066BPWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
CD4066BPWRG4	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD4066BM96	SOIC	D	14	2500	340.5	336.1	32.0
CD4066BM96G4	SOIC	D	14	2500	356.0	356.0	35.0
CD4066BM96G4	SOIC	D	14	2500	340.5	336.1	32.0
CD4066BMT	SOIC	D	14	250	210.0	185.0	35.0
CD4066BNSR	SO	NS	14	2000	356.0	356.0	35.0
CD4066BPWR	TSSOP	PW	14	2000	367.0	367.0	35.0
CD4066BPWRG4	TSSOP	PW	14	2000	356.0	356.0	35.0

TUBE


*All dimensions are nominal

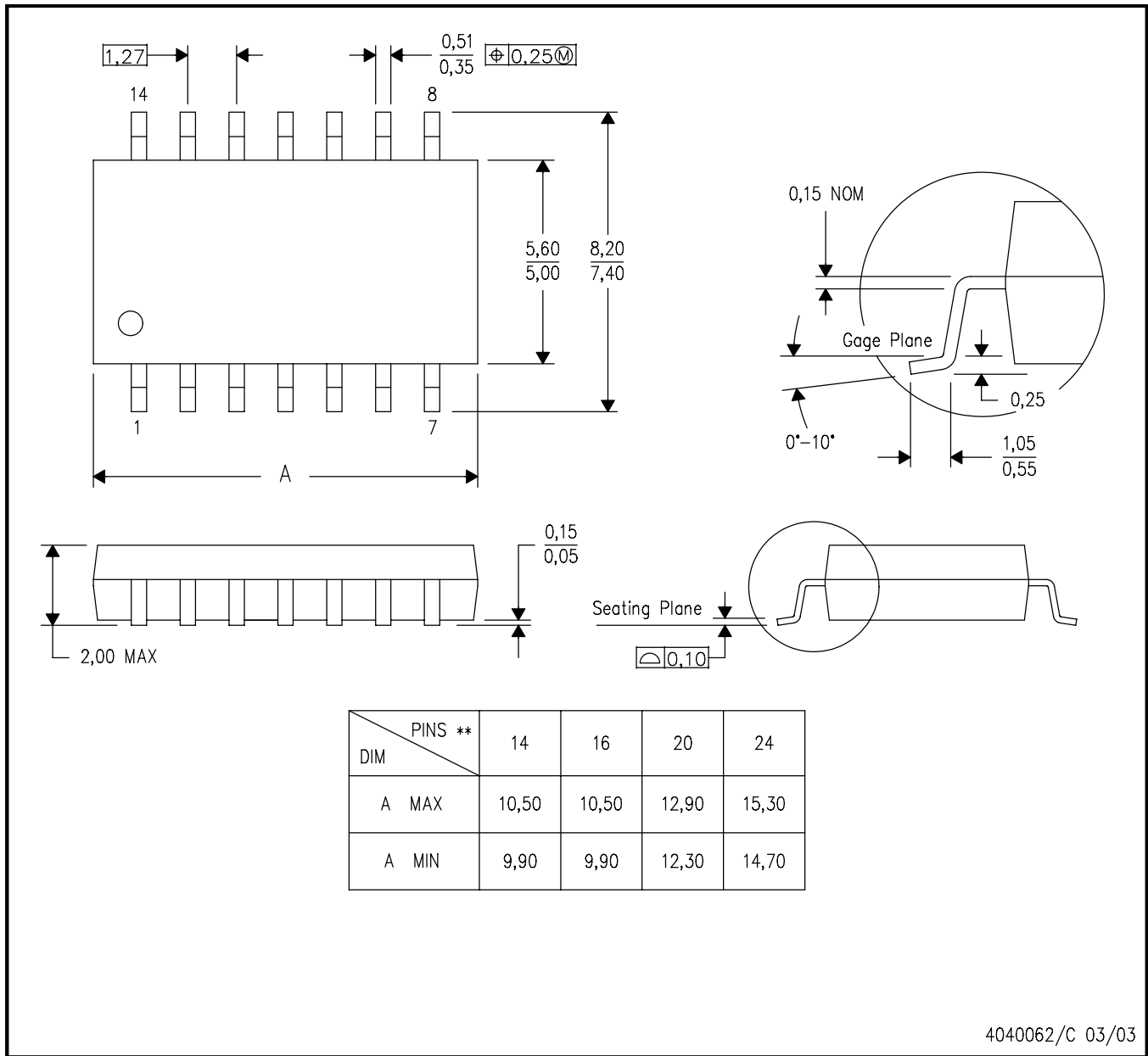
Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
CD4066BE	N	PDIP	14	25	506	13.97	11230	4.32
CD4066BE	N	PDIP	14	25	506	13.97	11230	4.32
CD4066BE	N	PDIP	14	25	506.1	9	600	5.4
CD4066BEE4	N	PDIP	14	25	506	13.97	11230	4.32
CD4066BEE4	N	PDIP	14	25	506	13.97	11230	4.32
CD4066BEE4	N	PDIP	14	25	506.1	9	600	5.4
CD4066BM	D	SOIC	14	50	506.6	8	3940	4.32
CD4066BNS	NS	SOP	14	50	530	10.5	4000	4.1
CD4066BPW	PW	TSSOP	14	90	530	10.2	3600	3.5
CD4066BPWG4	PW	TSSOP	14	90	530	10.2	3600	3.5

MECHANICAL DATA

NS (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

14-PINS SHOWN



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.

J 14

GENERIC PACKAGE VIEW
CDIP - 5.08 mm max height
CERAMIC DUAL IN LINE PACKAGE



Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

4040083-5/G

J0014A



PACKAGE OUTLINE

CDIP - 5.08 mm max height

CERAMIC DUAL IN LINE PACKAGE



4214771/A 05/2017

NOTES:

1. All controlling linear dimensions are in inches. Dimensions in brackets are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This package is hermetically sealed with a ceramic lid using glass frit.
4. Index point is provided on cap for terminal identification only and on press ceramic glass frit seal only.
5. Falls within MIL-STD-1835 and GDIP1-T14.

EXAMPLE BOARD LAYOUT

J0014A

CDIP - 5.08 mm max height

CERAMIC DUAL IN LINE PACKAGE



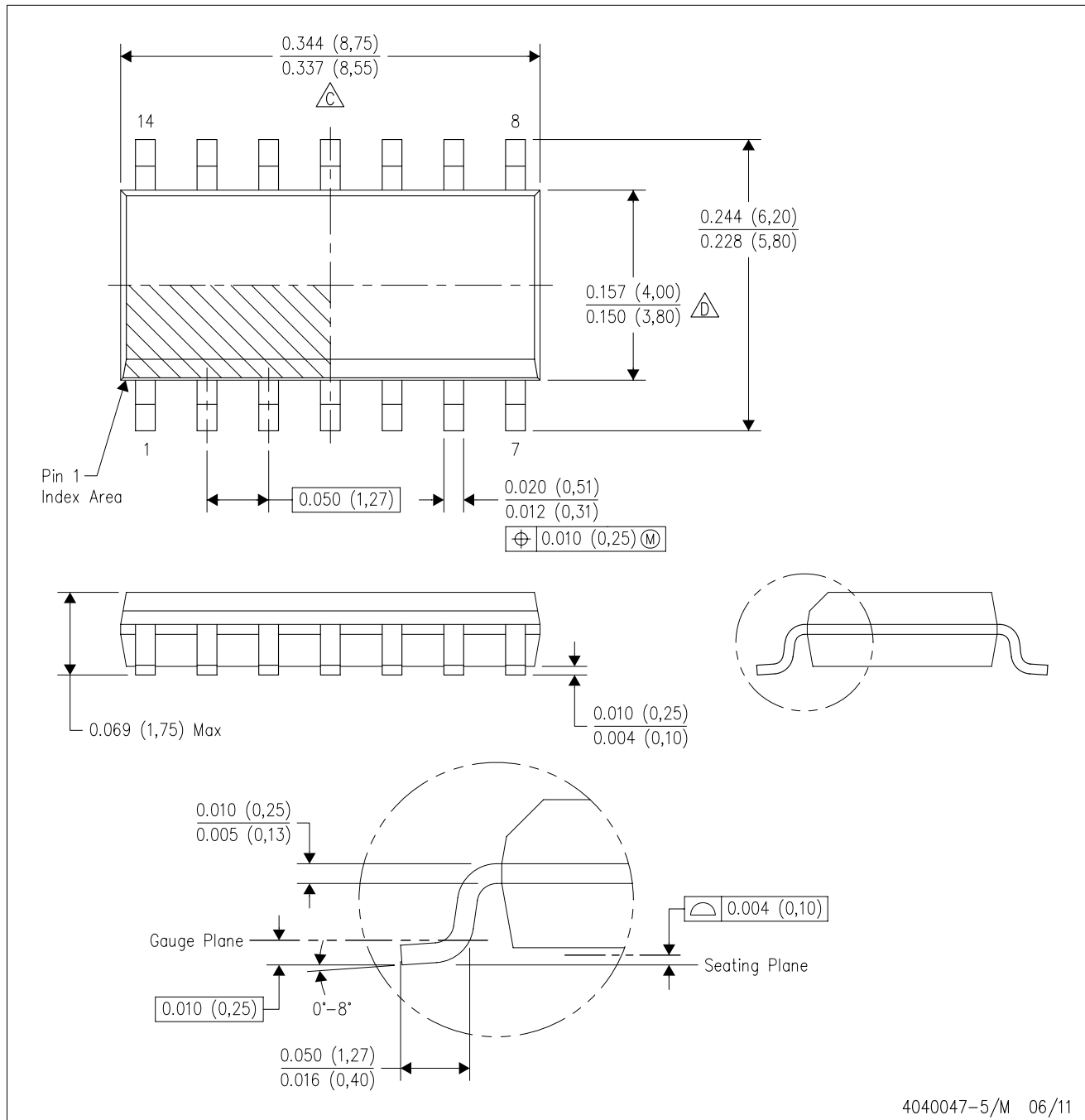
LAND PATTERN EXAMPLE
NON-SOLDER MASK DEFINED
SCALE: 5X



4214771/A 05/2017

D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
 - Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
 - E. Reference JEDEC MS-012 variation AB.

D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



4211283-3/E 08/12

- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Publication IPC-7351 is recommended for alternate designs.
 - D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
 - E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



4040064-3/G 02/11

- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - B. This drawing is subject to change without notice.
 - C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
 - D. Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
 - E. Falls within JEDEC MO-153

PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



4211284-2/G 08/15

- NOTES:
- All linear dimensions are in millimeters.
 - This drawing is subject to change without notice.
 - Publication IPC-7351 is recommended for alternate designs.
 - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
 - Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
 - The 20 pin end lead shoulder width is a vendor option, either half or full width.

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